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|-----------------------------|-------------------------|-------------------------|---------------|
| Subj. | Class | ISSUE CLASSIFICATION | SEARCHED |
| PAPERS | | | |
| UTILITY | | PATENT DATE | |
| SERIAL NUMBER 137021.167 | FILING DATE 12/17/96 | CLASS 26 | SUBCLASS 7 |
| | | GROUP ART. UNIT 2603 | EXAMINER 4 |

APPLICANT'S
HIROAKI MURAYAMA, TOKYO, JAPAN.

**CONTINUING DATA
VERIFIED

[Signature]

FOREIGN APPLICATIONS

VERIFIED JAPAN 8-338403

12/18/96

[Signature]

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|---|---|--|----------|-------------------------|-------------|--------------------|--------------------|---------------------------------|------------------------------------|
| Foreign priority claimed 35 USC 119 conditions met | <input type="checkbox"/> yes <input checked="" type="checkbox"/> yes | <input type="checkbox"/> no <input type="checkbox"/> no | AS FILED | STATE OR COUNTRY JPA | SHEETS 6 | TOTAL CLAIMS 10 | INDEP. CLAIMS 1 | FILING FEE RECEIVED \$790.00 | ATTORNEY'S DOCKET NO. NEC-19654 |
|---|---|--|----------|-------------------------|-------------|--------------------|--------------------|---------------------------------|------------------------------------|

Verifier and Acknowledged
Examiner's Initials

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ADDRESS

TITLE

CONTACT STRUCTURE IN SEMICONDUCTOR INTEGRATED CIRCUIT AND METHOD FOR
FORMING THE SAME

U.S. DEPT. OF COMM./PAT. & TM—PTD-438L (Rev.12-94)

[Signature]
DMW